

Notice of References Cited	Application/Control No. 10/693,209	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Phu Vu	Art Unit 2871	Page 1 of 1

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*	D	US-6,801,274	10-2004	Suzuki, Nobutaka	349/106
*	E	US-4,876,165	10-1989	Brewer et al.	430/7
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NON-PATENT DOCUMENTS

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